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SERIAL NUMBER 10/717,540	FILING DATE 11/21/2003 RULE	CLASS 345	GROUP ART UNIT 2673	ATTORNEY DOCKET NO. 245903US-2 CONT
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APPLICANTS

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CONTINUING DATA **

This application is a CON of 09/789,543 02/22/2001 ABN

** FOREIGN APPLICATIONS ****

IF REQUIRED, FOREIGN FILING LICENSE GRANTED

** 02/19/2004

Foreign Priority claimed	<input type="checkbox"/> yes <input checked="" type="checkbox"/> no	STATE OR COUNTRY	SHEETS	TOTAL CLAIMS	INDEPENDENT CLAIMS
35 USC 119 (a-d) conditions met	<input type="checkbox"/> yes <input checked="" type="checkbox"/> no <input type="checkbox"/> Met after Allowance	JAPAN	7	20	4
Verified and Acknowledged	Examiner's Signature	Initials			

ADDRESS

22850
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TITLE

Apparatus and method for testing electrode structure for thin display device using FET function

FILING FEE	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:	<input type="checkbox"/> All Fees <input type="checkbox"/> 1.16 Fees (Filing) <input type="checkbox"/> 1.17 Fees (Processing Ext. of time)
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